EMC TEST REPORT

According to FCC CFR47 Part 18 Subpart C

JOB Number : LBE042343

1. *This test reports does not constitute an endorsement by NIST/NVLAP or U.S Government.*
2. *This test report is to certify that the tested device properly complies with the requirements of FCC Rules and Regulations Part 18 CFR47 Subpart C Intentional Radiators. All tests necessary to show compliance to the requirements were and these results met the specifications requirement.*

This laboratory is registered by the NIST/NVLAP, U.S.A. The test reported herein have been performed in accordance with its terms of registration.

NVLAP LAB CODE 200623-0

1. Applicant Name : SAMSUNG ELECTRONICS CO., LTD.
416 Maetan-3 Dong, Yeongtong-Gu, Suwon-Si,
Gyeonggi-Do, Korea, 443-742

2. Identification of tested device

2.1 FCC ID : A3LMC769N
2.2 Device Name : MICROWAVE OVEN
2.3 Trade Name : Samsung Electronics Co.,Ltd.
2.4 Model Number : MC1360WA
Variant Model :
2.5 RF Output Power : **950** W (by IEC 705 method)

3. Test Procedure and Items

3.1 FCC/OST MP-5 : 1986

4. Issued Date : Jan 10, 2005

Tested by: J. Y Park

Jay Yong, PARK / Test Engineer

Reviewed by: N. C. Park

No Cheon, PARK / Manager of EMC Lab.

Authorised by: K. B. Chung

Kyu Baek, CHUNG / Chief of EMC Lab.

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5. Measurement Equipment List

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1. Product Description

The equipment under test is a microwave oven sold for consumer use.
Model : MC1360WA is a 950 W microwave oven with digital controls.
Installation Type: Over-the-range
Clock Frequency : 8.0MHz

< Magnetron >
Model : OM-75P manufactured by Samsung Electronic Co., Ltd.

2. Test Facility

The Semi-anechoic chamber and Conducted measurement facilities used to collect the radiated data are located at 416 Maetan 3 Dong, Yeongtong-Gu, Suwon-Si, Kyungki-Do, Korea.
The sites are constructed in conformance with the requirements of ANSI C63.4 and CISPR Publication 22.

3. Accreditation and Listing

The test facilities used to perform radiated and conducted emissions tests are accrediated by National Voluntary Laboratory Accreditation Program for the specific of accreditation under Lab Code: 200623-0 to perform Electromagnetic Interference tests according to FCC PART 15 and CISPR 22 requirements.
No part of this report may be used to claim or imply product endorsement by NVLAP or any agency of the US Government.

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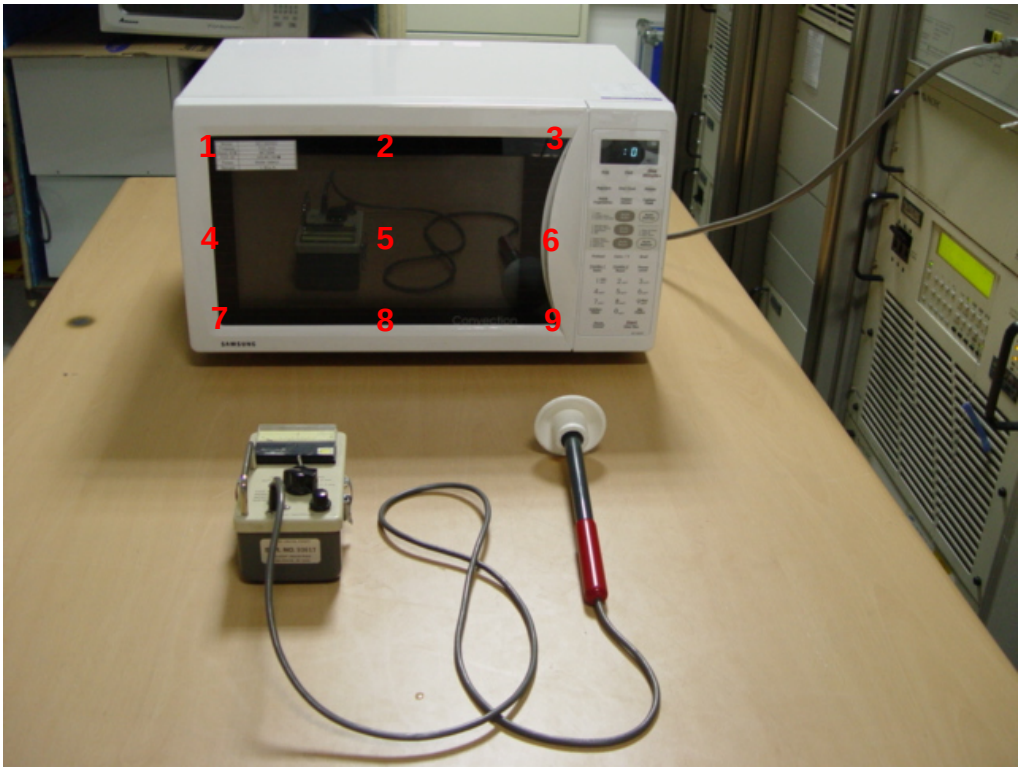
4. Radio Noise Emission Measurement Procedures/Results

4.1 Radiation Hazard Measurement

A 700-ml water load was placed in the center of the oven.
The power setting was set to maximum power.
While the oven was operating, the Microwave Survey Meter probe was moved slowly around the door seams to check for leakage.



The results of this test are as follows.

Probe Location	Maximum Leakage [mW/Cm2]	Limit [mW/Cm2]
1	0.10	1.0
5	0.05	1.0
6	0.05	1.0
All others	0.05	1.0

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4.2 Input Power Measurement

Input power and current were measured using a Power Analyzer.
A 700ml water load was placed in the center of the oven and the oven set to maximum power. A 700 ml water load was chosen for its compatibility. Manufacturers to determine their input ratings commonly use this procedure.

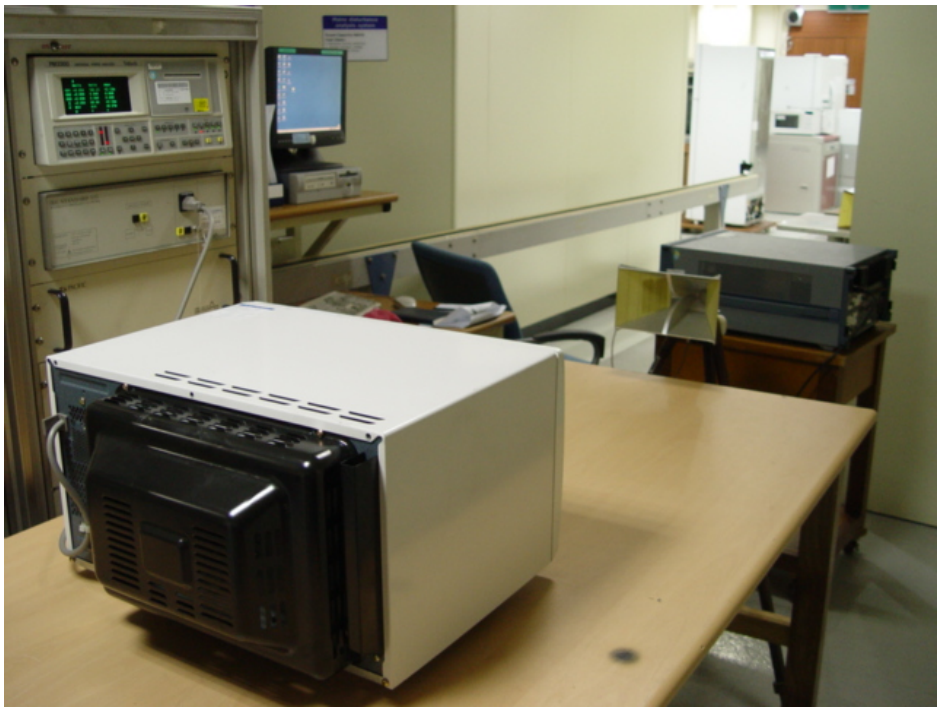

Fig. 2 Test Setup for Input power

The results of this test are as follows.

Input Voltage [Vac]	Input Current [amps]	Measured Input power [watts]	EUT Spec. Input power [watts]
120	**12.4**	**1448**	**1450**

Based on the measured input power, the EUT was found to be operating within the intended specifications.

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4.3 RF Output Power Measurement

The Caloric Method was used to determine maximum output power.
The initial temperature of a 1000-ml water load was measured. The water load was placed in the center of the oven. The oven was operated at maximum output power for 120 seconds. Then the temperature of the water re-measured.

Fig.3 Test Setup for RF output power

Quantity of water [ml]	Starting Temperature [centigrade]	Final Temperature [centigrade]	Elapsed Time [seconds]	RF Power [watts]
1000	10	**30.5**	120	715.3
1000	10	**29.4**	120	676.9
1000	10	**29.3**	120	673.4
Average RF Power of 3 Trials				688.5

$$\textbf{Power} = \frac{(4.187\ \text{Joules/Cal}) \times (\text{Volume in ml}) \times (\text{Temp. Rise})}{\text{Time in seconds}}$$

The measured output was found to be **ABOVE 500Watts**. Therefore, in accordance with section 18.305 of Subpart C, the measured out-of-band emissions were compared to the 25xSQRT(power/500)[uV/m] @ 300M limit.

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4.4 Operation Frequency Measurement

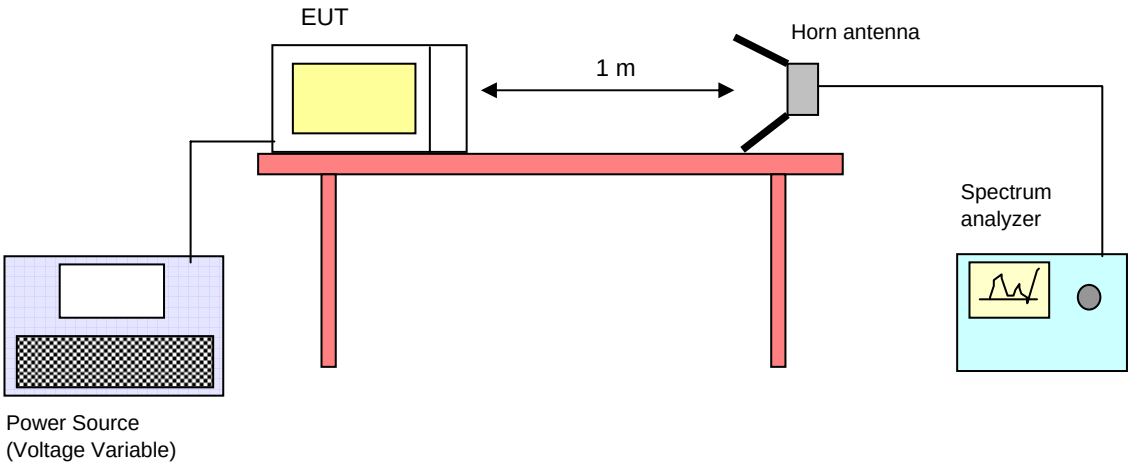
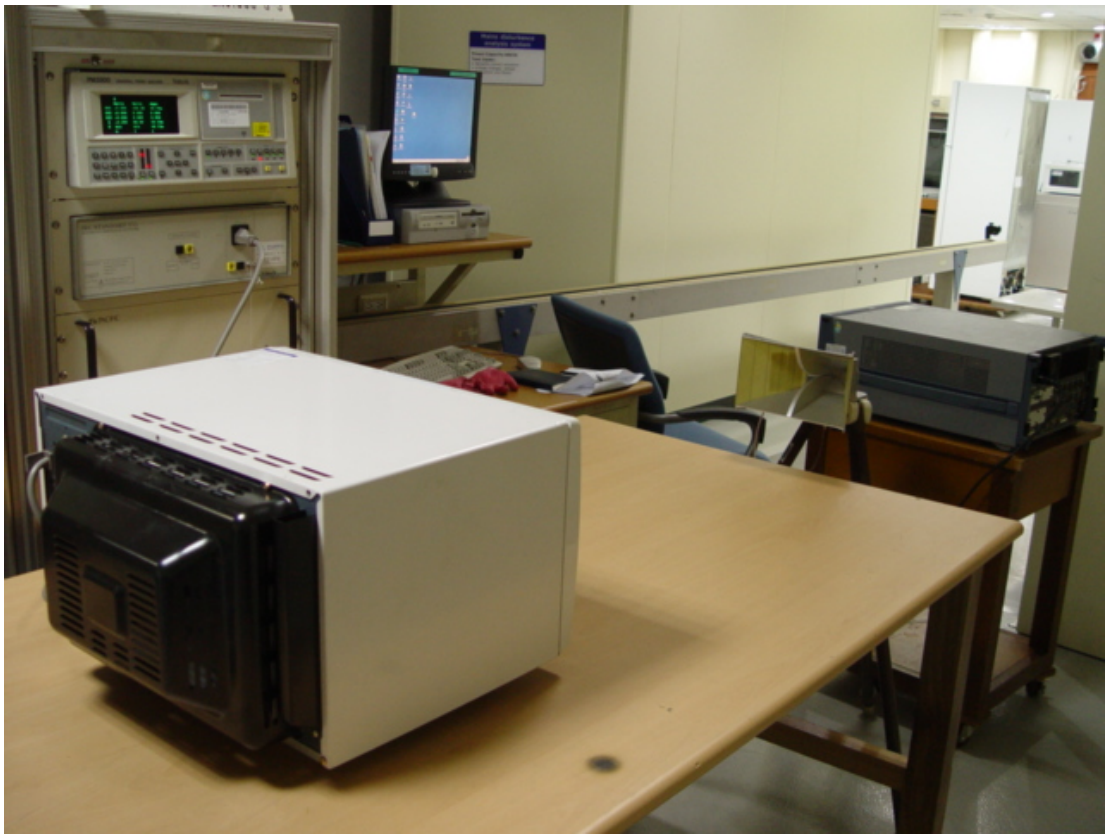


Fig. 4 Operating Frequency Measurements Configuration



4.4.1 Frequency Measurement

Following the above test, after operating the oven long enough to assure that stable operating temperature were obtained, the operating frequency was monitored as the input voltage was varied between 80 to 125 percent of the nominal rating.

The results of this test are as follows.
Line voltage varied from 96Vac to 150Vac.

Initial load : 1000 ml water in the glass beaker

(1) Frequence vs Line Voltage Variation Test

[Room Temperature : 23.0 ℃]

Line Voltage Variation (V)	Frequency (MHz)	Allowed Tolerance for the ISM Band (2450MHz)
150 (125%)	Lower : 2453	Lower: 2400 MHz Upper : 2500 MHz
	upper : 2464	
132(110%)	Lower : 2453	
	upper : 2465	
120 (Nominal)	Lower : 2456	
	upper : 2467	
108 (90%)	Lower : 2451	
	upper : 2466	
96 (80%)	Lower : 2450	
	upper : 2465	

Result : PASSED

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(2) Frequence vs Load Variation Test

Initial load : 1000 ml water in the glass beaker

[Room Temperature : 23 ℃]

Volume of Water (cc)	Frequency (MHz)		Allowed Tolerance for the ISM Band (2450MHz)
1000	Lower :	2456	Lower: 2400 MHz Upper : 2500 MHz
	upper :	2467	
800	Lower :	2435	
	upper :	2469	
600	Lower :	2424	
	upper :	2467	
400	Lower :	2453	
	upper :	2466	
200	Lower :	2447	
	upper :	2461	

Note : Frequency was measured by using nominal voltage (AC120V)

Result : PASSED

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4.5 Conducted Emission Measurement

4.5.1 Conducted Emission Measurement Procedure

Configurate the EUT System in accordance with ANSI C63.4-2003
Connect the EUT's AC line cord to the EUT port of LISN.
All input terminals are terminated in the proper impedance.
The output ports are connected to the cable provided with the device and the ending port are terminated in the proper impedance.

Using a calibrated coaxial cable, the TEST RECEIVER is connected to the measuring port of the LISN for EUT.
To find out the maximum emission, change the position of the cable, and the EUT operation mode under normal usage of the EUT.
Then, the emission are scanned from 0.15MHz to 30MHz relative to the limit are recorded.

4.5.2 Radiated Emission Measurement Configuration

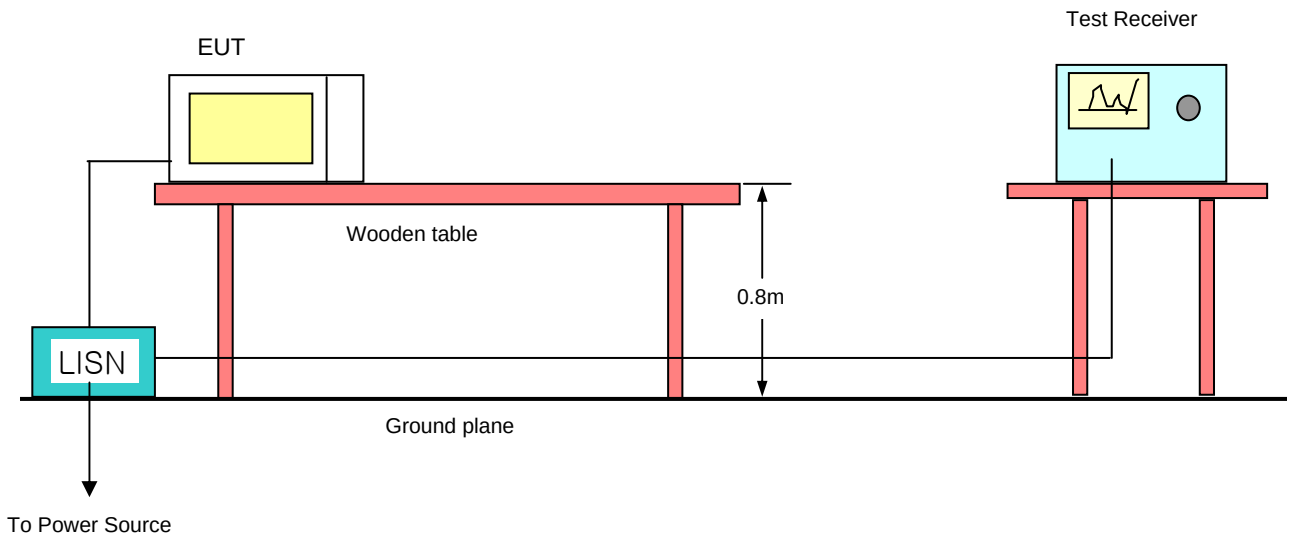


Fig. 5 Conducted Emission Configuration(0.15 - 30MHz)

4.5.3 Conducted Emission Measurement Data(0.15 - 30MHz)

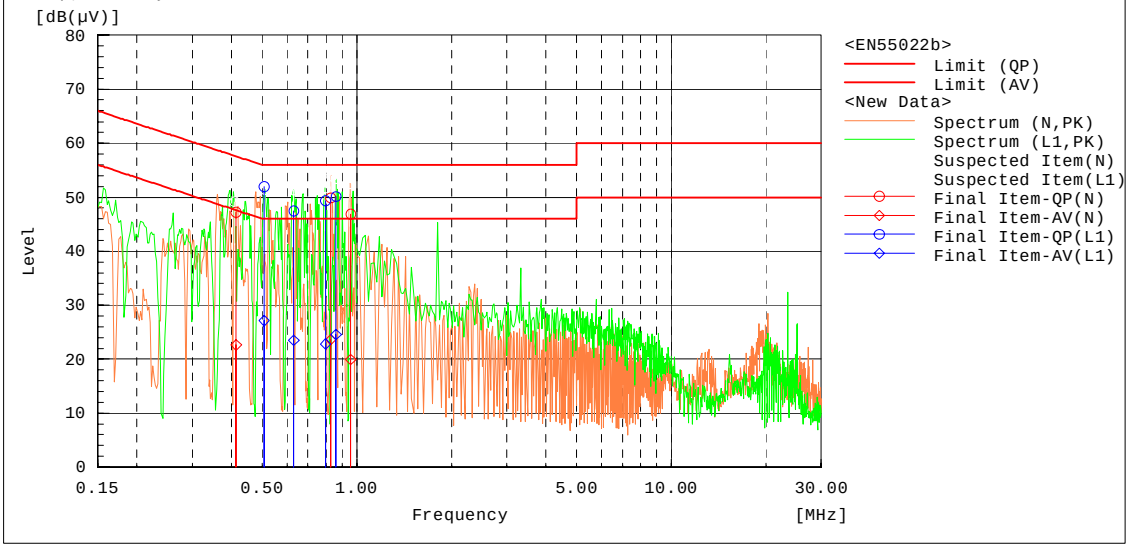
Samsung
- EMC Site -

<<Conducted Emission>>

29 December,2004 10:35

Model : MC1360WA
Projecte Num :
Operator :
OP Mode :
Temp,Humidity:

Standard : EN 55022 (ITE) Class B
Remark1 :
Remark2 :
Remark3 :
Remark4 :



Final Result

--- N Phase ---

No.	Frequency [MHz]	Reading QP [dB(μV)]	Reading AV [dB(μV)]	c.f [dB]	Result QP [dB(μV)]	Result AV [dB(μV)]	Limit QP [dB(μV)]	Limit AV [dB(μV)]	Margin QP [dB]	Margin AV [dB]
1	0.4135	47.1	22.5	0.1	47.2	22.6	57.6	47.6	10.4	25.0
2	0.82643	49.7	23.4	0.2	49.9	23.6	56.0	46.0	6.1	22.4
3	0.95727	46.6	19.7	0.2	46.8	19.9	56.0	46.0	9.2	26.1

--- L1 Phase ---

No.	Frequency [MHz]	Reading QP [dB(μV)]	Reading AV [dB(μV)]	c.f [dB]	Result QP [dB(μV)]	Result AV [dB(μV)]	Limit QP [dB(μV)]	Limit AV [dB(μV)]	Margin QP [dB]	Margin AV [dB]
1	0.50836	51.9	27.0	0.1	52.0	27.1	56.0	46.0	4.1	18.9
2	0.63053	47.4	23.4	0.1	47.5	23.5	56.0	46.0	8.5	22.5
3	0.79611	49.2	22.7	0.1	49.3	22.8	56.0	46.0	6.7	23.2
4	0.8589	50.0	24.5	0.1	50.1	24.6	56.0	46.0	5.9	21.4

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4.6 Radiated Emission Measurement

4.6.1 Radiated Emission Measurement Procedure

Radiated emission were measured over an inclusive frequency range to 30MHz through the tenth harmonic of the operating frequency. For this test, a 0.8-meter high wooden table in a semi-anechoic chamber supported the device under test. The table was placed on a turntable.

The measurement antenna was placed 3 meters for measurement from 30 to 1,000MHz and 1 meter for measurement from 1 - 25GHz, respectively, for the device under test. The indicated frequency range was swept as device under test was rotated along its vertical axis in 90 degree increments.

During the preliminary tests, the load consisted of 700-ml tap water placed in the center of the oven. The emissions were observed while the device under test was operated at maximum output power.

The level of the emissions near the edge of the designated ISM frequency band was measured. For this test, the load consisted of 700-ml water load located in the center of the oven.

The level of the second and third harmonic were measured inclusively with a 300-ml and 700-ml water load alternately placed in the center and side(or right front corner) of the oven.
The data obtained during these tests is contained on this report.

All other out-of-band emissions were measured while a 700-ml load was placed in the center of the oven. Maximum readings were recorded after variations in antenna polarizations, height, device orientation, load position, and size.
For frequencies above 1GHz, the test receiver detecting mode was set to average detection mode(Model no.:ESI , Rohde & Schwarz).

For all emissions the equivalent 300 meters intensity was calculated assuming linear decrease in the described, there were no over-limit emissions discorvered.

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4.6.2 Radiated Emission Measurement Configuration

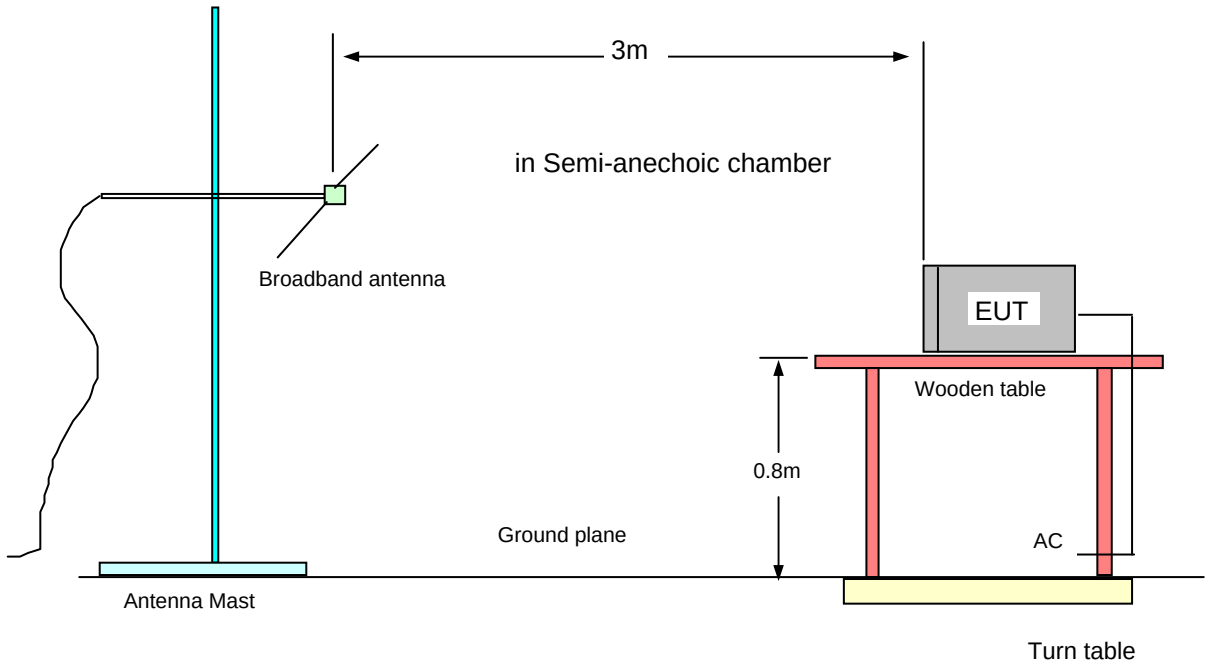

Fig. 6 Radiated Emission Configuration(30 - 1000MHz)

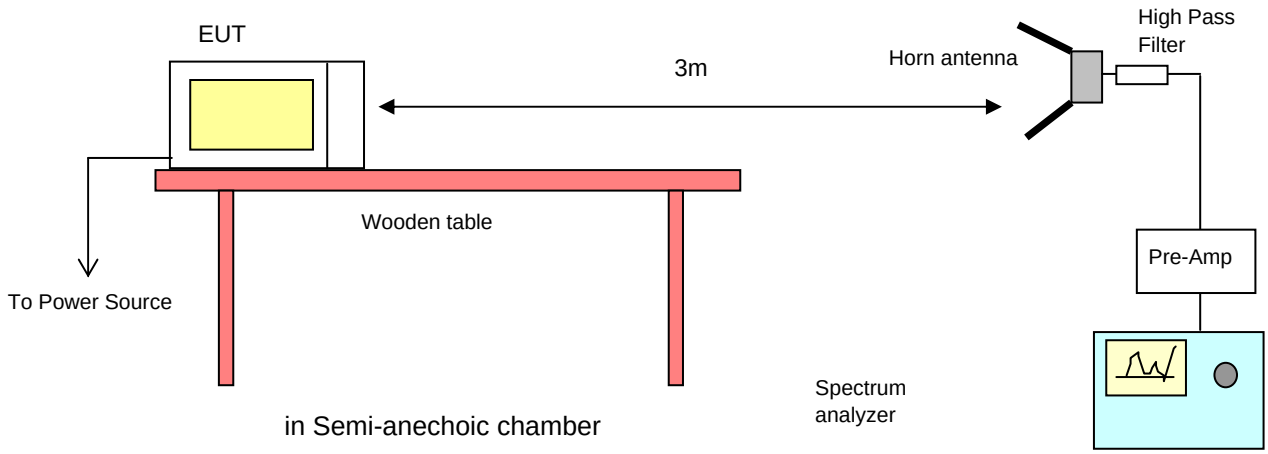

Fig. 7 Radiated Emission Configuration(1 - 25GHz)

4.6.3 Radiated Emission Measurement Data(30 - 1000MHz)

Test distance : 3m

Tested Frequency [MHz]	Meter Reading [A] [dBuV]	Total Loss [B] [dB]	Results [A+B] [dBuV/m]	Limits at 300m [dBuV/m]	ANT Pol.	Margin (Limit-Result) [dB]	Antenna Height [Cm]	Turn table Degree [Deg]
	Pk		**Pk**			**Pk**		
277.5	57.1	-8.5	48.6	69.35	H	20.75	100	0
282.9	55.3	-8.3	47.0	69.35	H	22.35	100	0
591.6	54.7	-1.8	52.9	69.35	H	16.45	100	0
614.6	48.3	-1.2	47.1	69.35	V	22.25	100	0
637.6	50.1	-0.5	49.6	69.35	H	19.75	100	0
923.9	52.5	3.4	55.9	69.35	H	13.45	100	0
946.9	49.9	3.7	53.6	69.35	V	15.75	100	0
959.3	49.2	4.0	53.2	69.35	H	16.15	100	30

[NOTE]

** fo = 2450MHz*

** Test distance : 3m*

** Results = Meter Reading + Total Loss(Antenna factor + Cable loss)*

** Distance Correction factor : 20 x log(d1/d2)[dBuV/m]*

20 x log(300/3) = + 40dBuV/m

** The limit at 300 meters is* 29.35 *dBuV/m.*

Add 40dB 29.35 *dBuV/m gives a* 69.35 *dBuV/m @ 3 meters.*

** Spectrum analyzer setting*

Peak(Pk) : Resolution Bandwidth(1MHz), Video Bandwidth(1MHz)

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4.6.4 Radiated Emission Measurement Data(1 - 25GHz)

Test distance : 3m

Tested Frequency [MHz]	Meter Reading [dBuV]	Total Loss [dB]	AMP [dB]	HPF [dB]	k Factor	Results [dBuV/m]	Limits at 300m [dBuV/m]	ANT Pol.	Margin [dB]
1253	43.0	24.9	38.9	0	0.0023	0.07	29.35	V	29.28
2317	61.1	27.5	39.4	0	0.0060	1.72	29.35	V	27.63
2398	61.3	27.9	38.9	0	0.0062	2.04	29.35	V	27.31
2513	54.2	29.6	35.4	0	0.0065	1.70	29.35	V	27.65
2561	46.8	29.8	34.2	0	0.0066	0.87	29.35	V	28.48
2925	40.1	33.1	31.5	0	0.0074	0.90	29.35	V	28.45
4922	65.3	35.2	41.8	1	0.01	9.63	29.35	V	19.72
7075	54.4	40.2	41.5	1	0.01	5.06	29.35	V	24.28
7398	61.2	39.8	41.5	1	0.01	10.59	29.35	V	18.76
9853	70.5	38.1	41.5	1	0.01	25.44	29.35	V	3.91
11385	41.2	37.6	41.1	1	0.01	0.86	29.35	V	28.49
12298	40.5	41.2	41.1	1	0.01	1.21	29.35	V	28.14
14747	42.4	41.6	42.1	1	0.01	1.39	29.35	V	27.96
17220	53.9	43.5	41.3	1	0.01	7.14	29.35	V	22.21

** **f**o = 2450MHz*
** **Total Loss** : Antenna Factor+ Cable Loss, **HPF** : High Pass Filter(4.5GHz)*
** **AMP** : Pre-amplifier*
** The limit at 300 meters is 20 * LOG (25 * RF Power/500)*
** Results : Field Strength abobe 1000MHz (at 300m)(uV/m) = K*10 [Field strengh at 3m(dBuV/m)/20]*
** Margin = Result-Limit*

[NOTE]

1. Load for measurement of radiation on second and third harmonic : Two loads, one of 1000ml and the other of 450ml, of water were used. Each load was tested both with the beaker located in the center of the oven and with it in the corner.

** k : Conversion Factor*

$K = 0.0137 * \log F - 0.0401$ (if $F < 4575$ MHz)

$K = 0.01$ (if $F \geq 4575$ MHz)

F = Meter Reading Frequency

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5. Measurement Equipment List

Equipment	Model No.	Serial No.	Makers	Calibration Last calibration and Interval
Field strength meter	ESCS30	839809/002	R & S	04/04/28, 12Months
	ESI26	832692/002	R & S	04/05/24, 12Months
Measurement Software	EP5RE	-	TOYO	N/A
Pre-Amplifier	8449B	3008A00705	H.P	04/07/20, 12Months
Double Ridged Guide Antenna	3115	9505-4441	EMCO	04/05/23, 24Months
Microwave Survey Meter	HI-1501	93661	H.I	04/10/02, 12Months
High Pass Filter	3H10-4500	2	K & L	04/11/11, 12Months
Amplifier	DWT-18213	004-9942	DSB Microwave	04/11/10, 12Months
Biconilog Antenna	CBL6112B	2767	SCHAFFNER	04/05/22, 12Months
Spectrum Analyzer	E7405A	MY42000052	Agilent	04/08/04, 12Months
Field strength meter	ESS	844661/005	R&S	04/01/05, 12Months
L.I.S.N	ESH3-Z5	100262	R&S	04/02/11, 12Months
Measurement Software	EP5CE	-	TOYO	N/A

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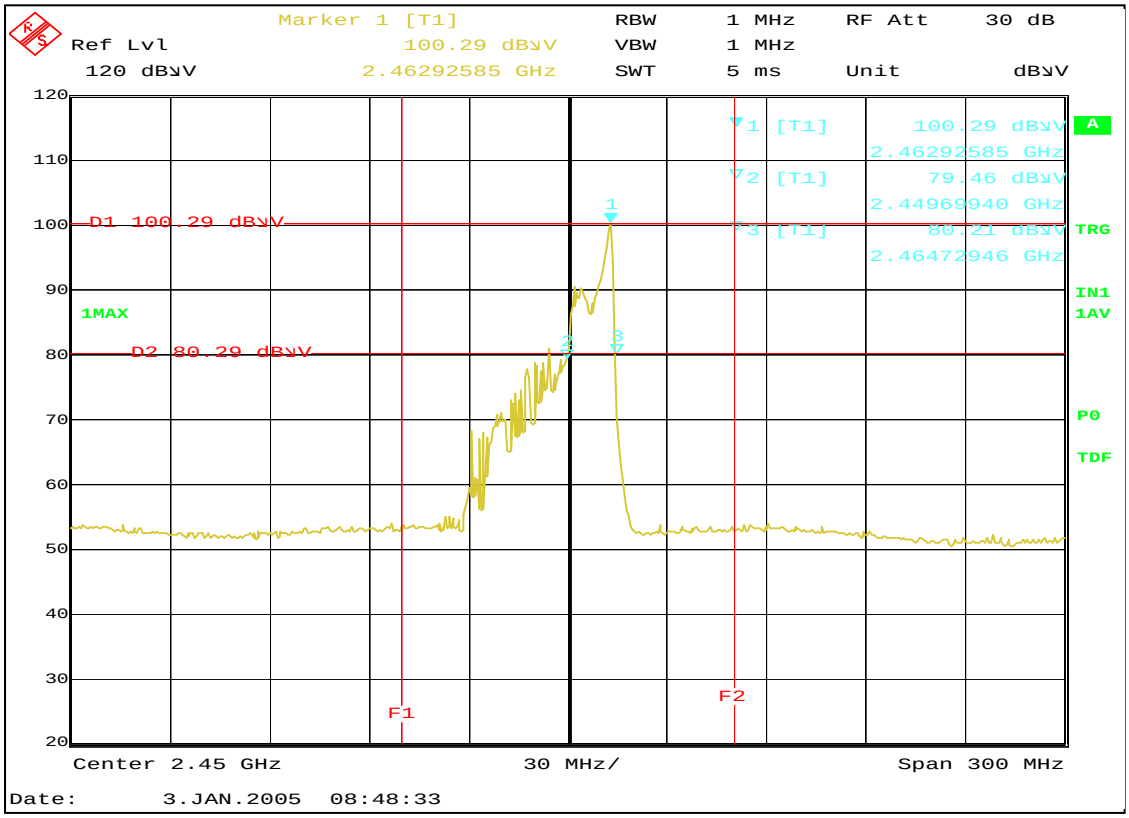
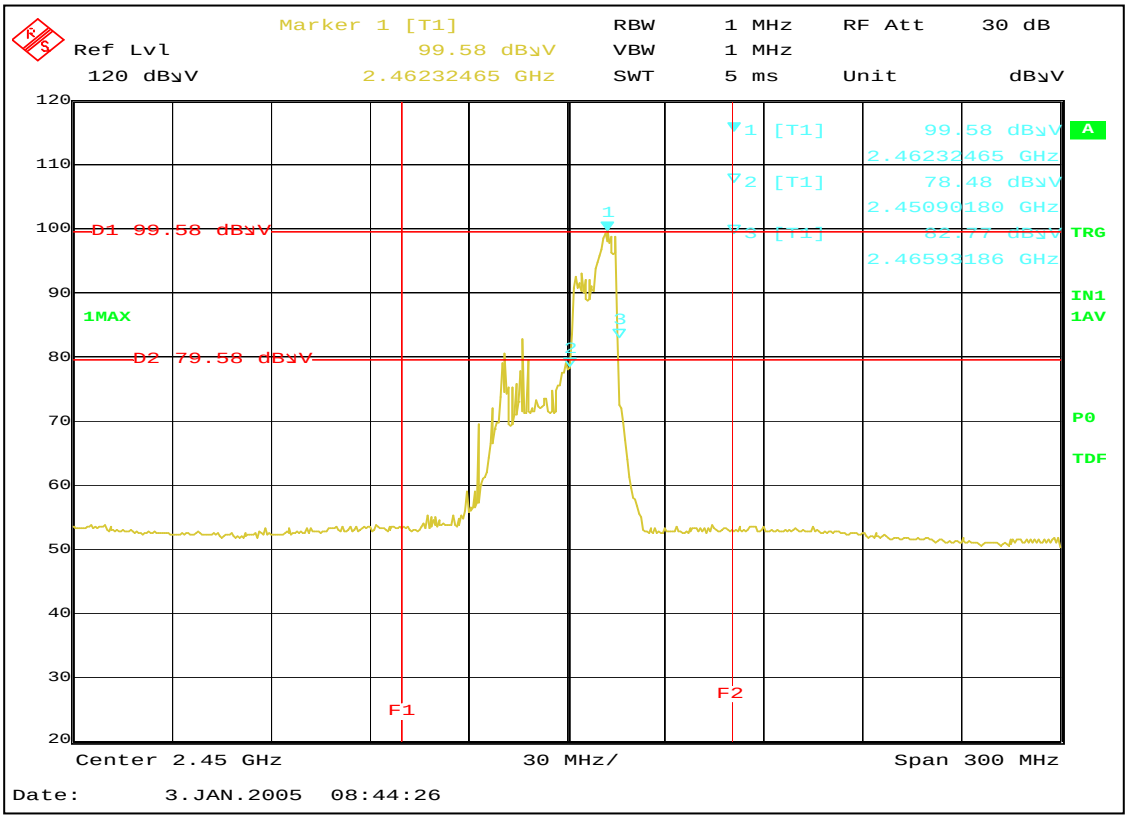
Frequence vs Line Voltage Variation Test

96V(80%)

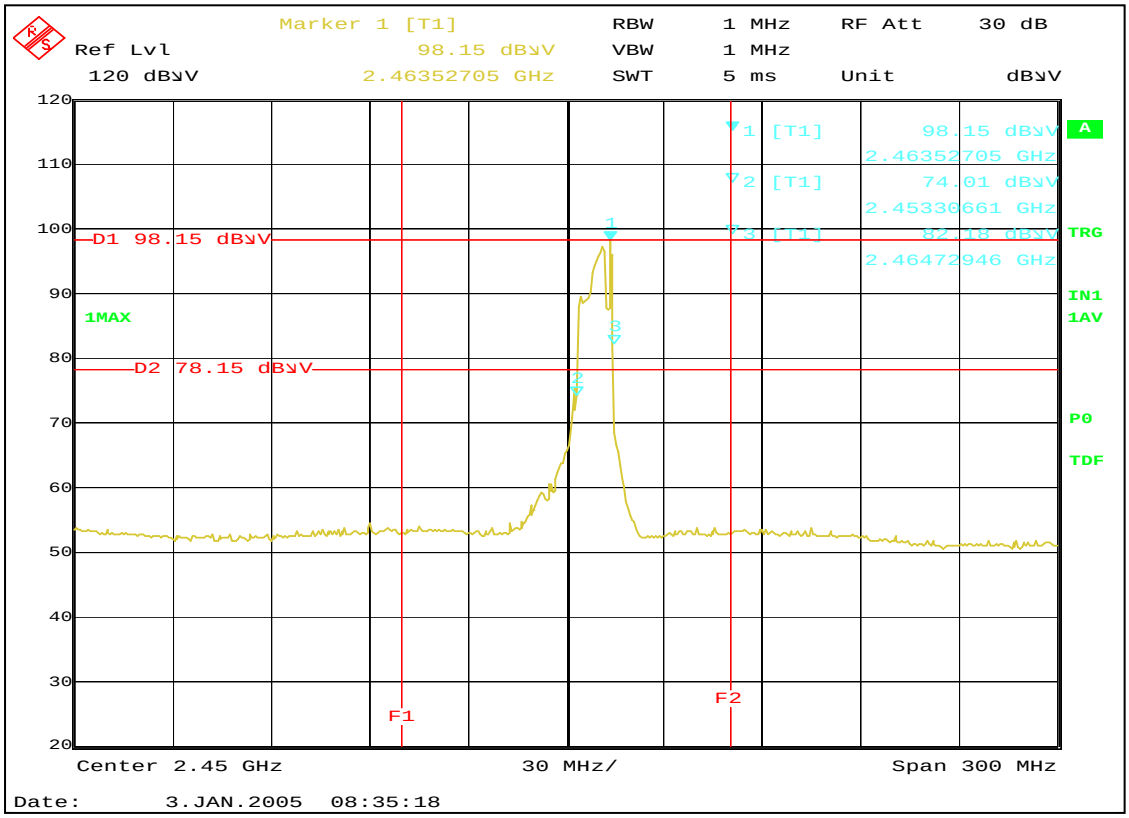


108V(90%)

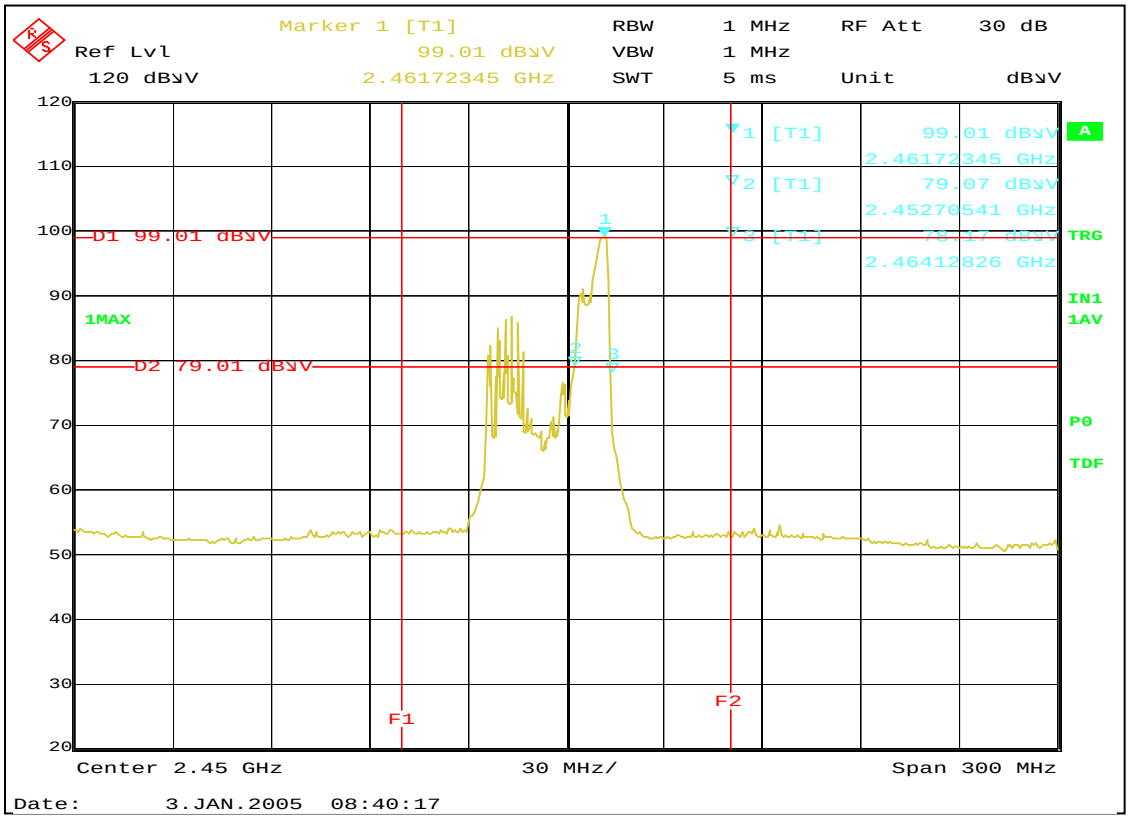


Frequence vs Line Voltage Variation Test

132V(110%)

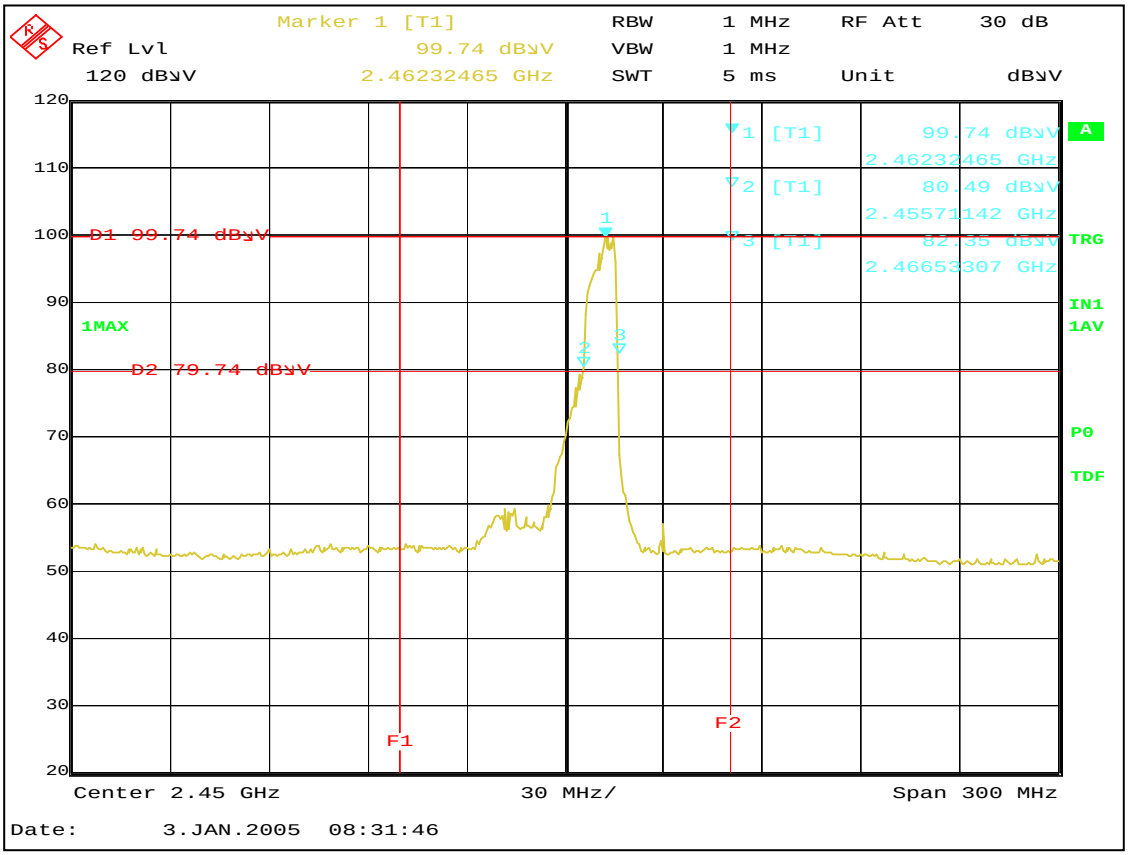


150V(125%)

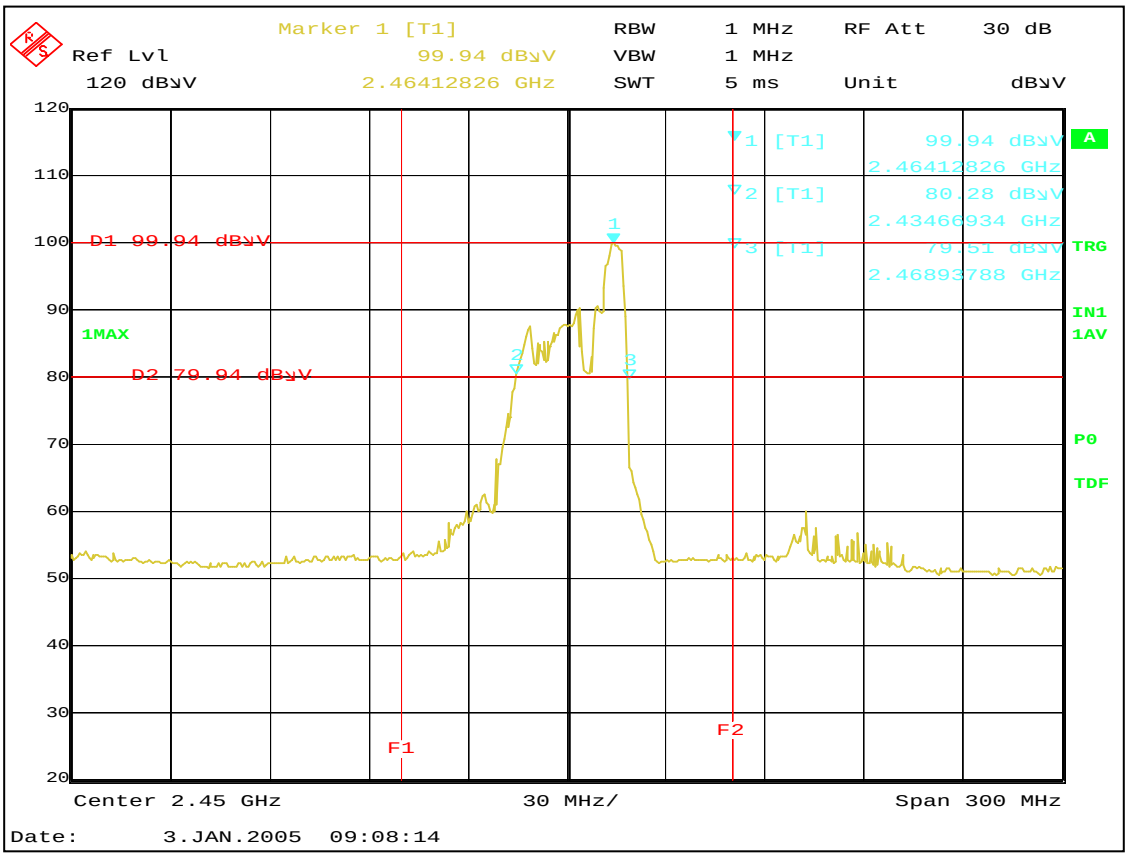


Frequence vs Load Variation Test

120V(1000ml)

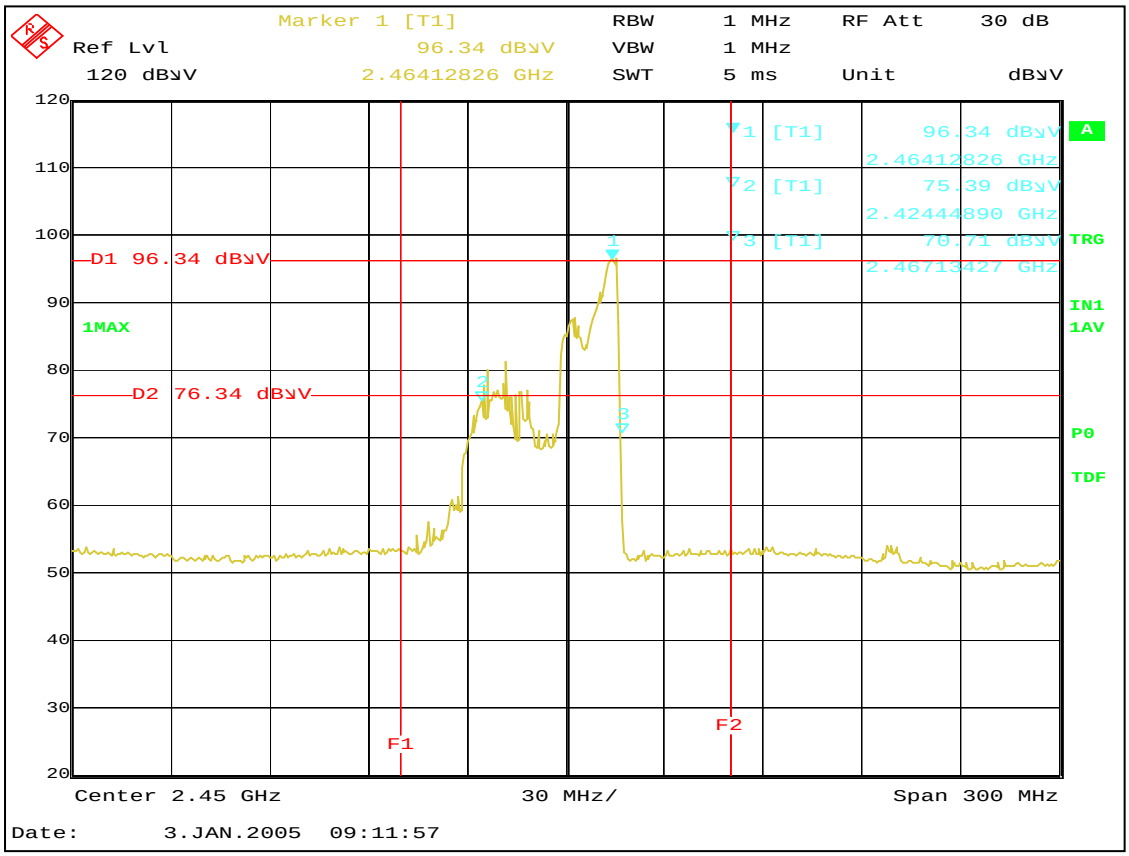


120V(800ml)

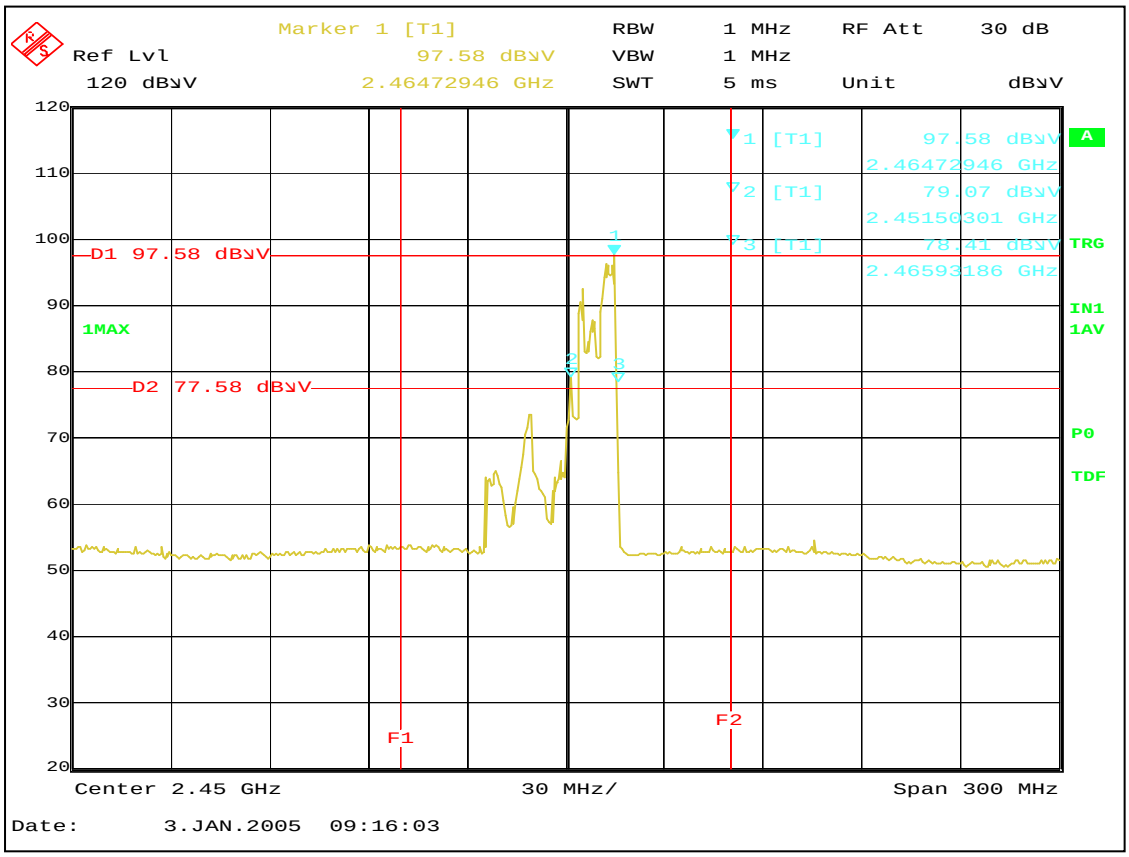


Frequence vs Load Variation Test

120V(600ml)

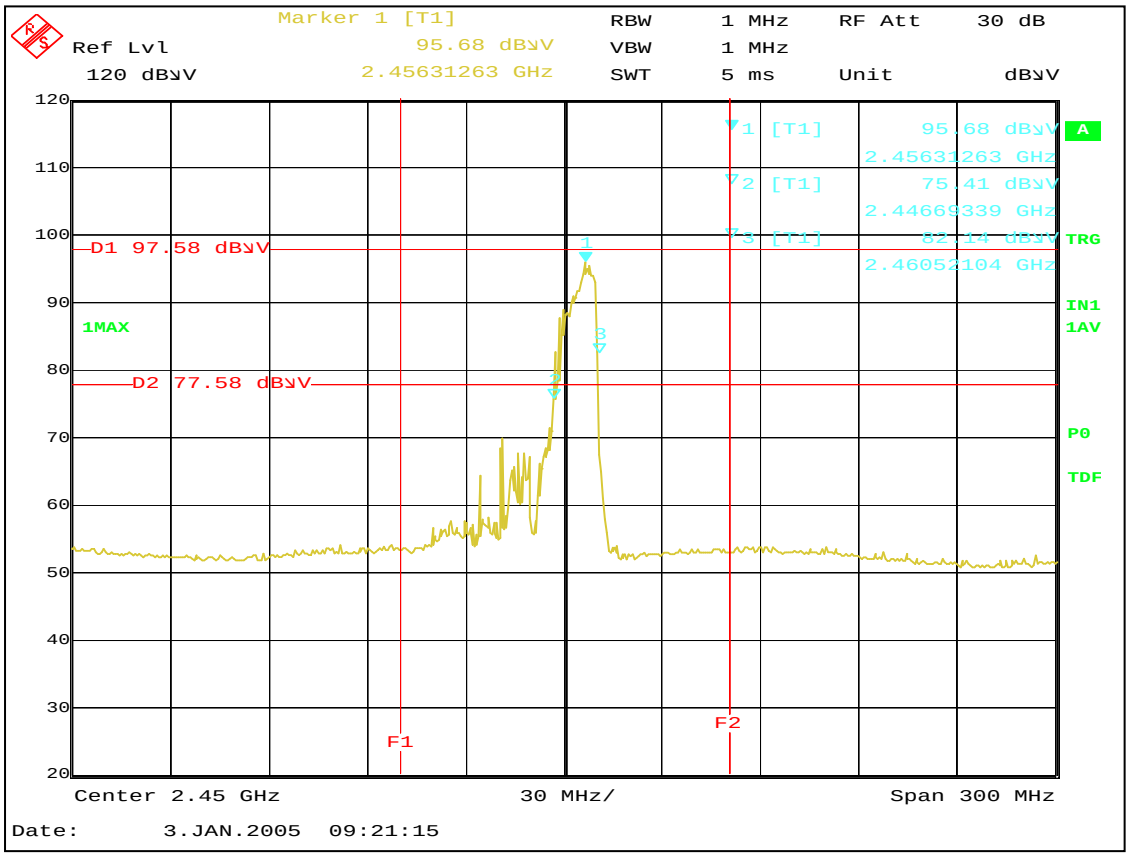


120V(400ml)

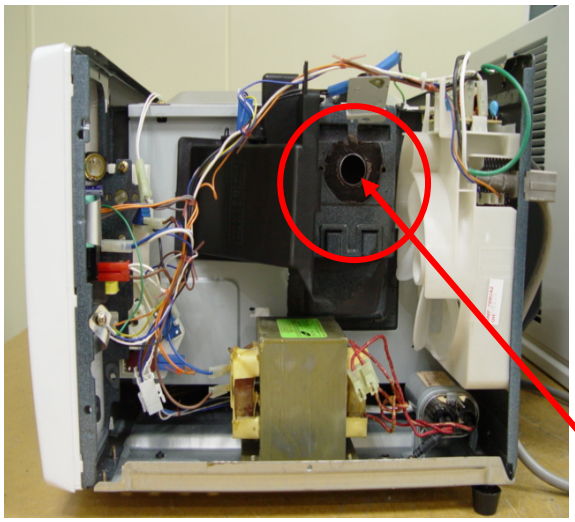


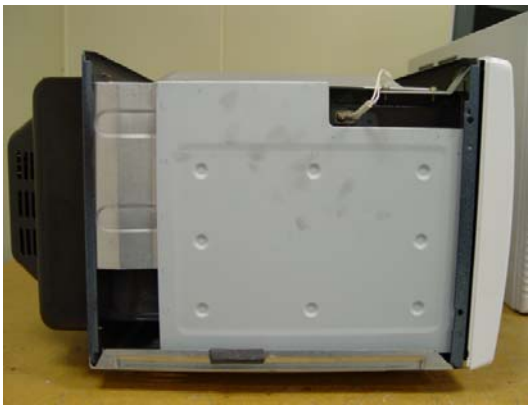
Frequence vs Load Variation Test

120V(200ml)

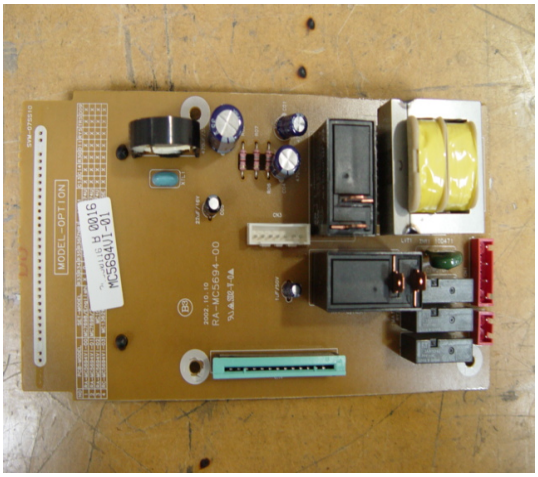


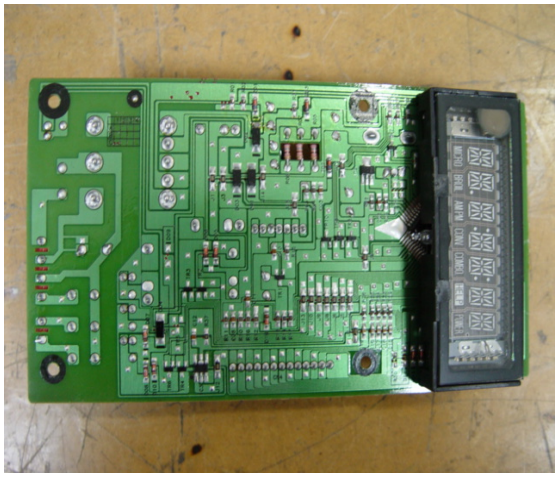
Convection
SAMSUNG



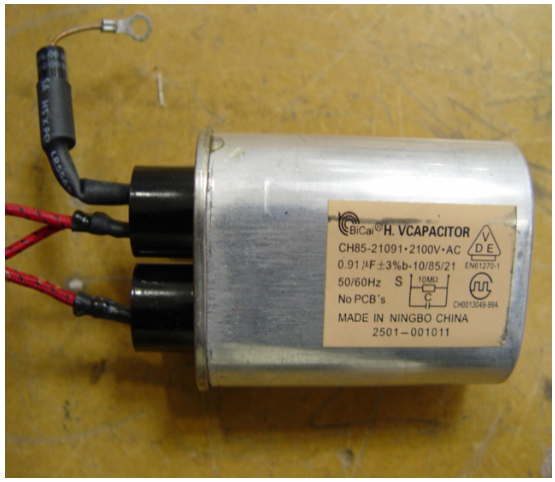


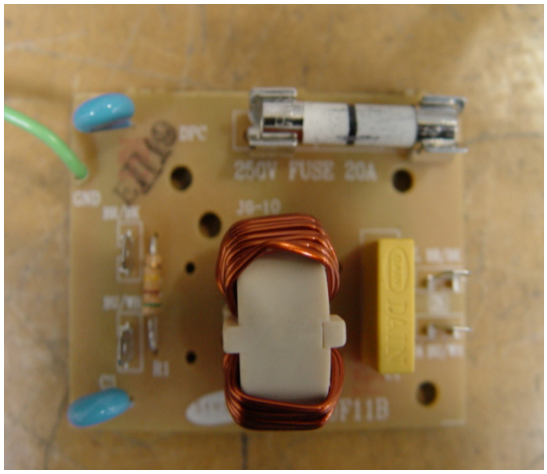
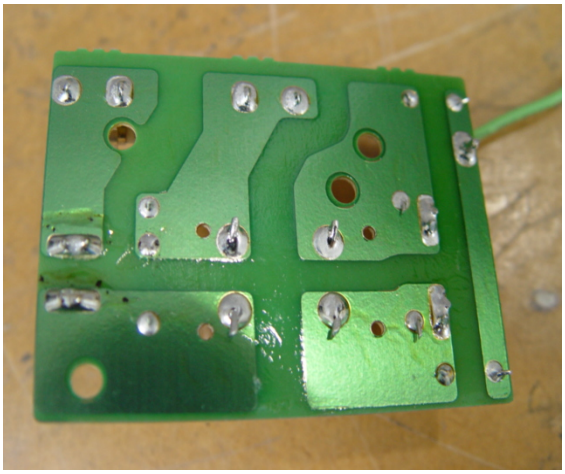
SAMSUNG
OM75P(31)
DANGER HIGH VOLTAGE
2NFC064469
MADE IN KOREA


MODEL-OPTION
MC5694VI-01
RA-MC5694-00



DANGER
HIGH VOLTAGE
DISCHARGE CAPACITOR BEFORE SERVICING
SAMSUNG
QBJY2
K H T-R
120V 60Hz
AC-CH JQ
SHV-U11KA
0212181
KOREAN ELECTRONICS POWER SOURCE CO.,LTD.


BiCal H. VCAPACITOR
CH85-21091·2100V·AC
0.91μF±3%b-10/85/21
50/60Hz
No PCB's
MADE IN NINGBO CHINA
2501-001011


250V FUSE 20A
F11B